

## 1. Product profile

### 1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

### 1.2 Features and benefits

- 100% gate resistance tested
- 100% Ruggedness tested
- Lead-free package
- Logic level compatible
- Optimized for use in DC-to-DC converters
- Very low switching and conduction losses

### 1.3 Applications

- DC-to-DC converters
- Notebook computers
- Switched-mode power supplies
- Voltage regulators

### 1.4 Quick reference data

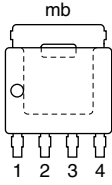
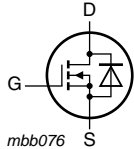
Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \geq 25\text{ °C}$ ; $T_j \leq 150\text{ °C}$	-	-	25	V
$I_D$	drain current	$T_{mb} = 25\text{ °C}$ ; $V_{GS} = 10\text{ V}$ ; see <a href="#">Figure 1</a> ; see <a href="#">Figure 3</a>	[1]	-	100	A
<b>Dynamic characteristics</b>						
$Q_{GD}$	gate-drain charge	$V_{GS} = 4.5\text{ V}$ ; $I_D = 25\text{ A}$ ; $V_{DS} = 12\text{ V}$ ; see <a href="#">Figure 12</a> ; see <a href="#">Figure 13</a>	-	8	-	nC
<b>Static characteristics</b>						
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10\text{ V}$ ; $I_D = 25\text{ A}$ ; $T_j = 25\text{ °C}$ ; see <a href="#">Figure 10</a> ; see <a href="#">Figure 11</a>	-	1.4	1.8	mΩ

[1] Continuous current is limited by package.

## 2. Pinning information

**Table 2. Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source	 <p><b>SOT669 (LFAK)</b></p>	
2	S	source		
3	S	source		
4	G	gate		
mb	D	mounting base; connected to drain		

## 3. Ordering information

**Table 3. Ordering information**

Type number	Package		Version
	Name	Description	
PH1825AL	LFAK	plastic single-ended surface-mounted package (LFAK); 4 leads	SOT669

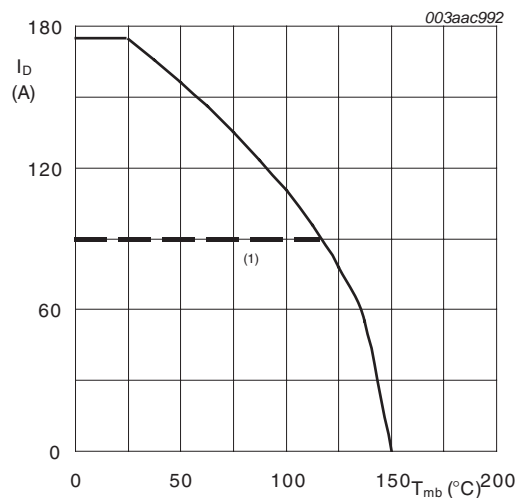
## 4. Limiting values

**Table 4. Limiting values**

*In accordance with the Absolute Maximum Rating System (IEC 60134).*

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \geq 25\text{ °C}$ ; $T_j \leq 150\text{ °C}$	-	25	V
$V_{DGR}$	drain-gate voltage	$T_j \geq 25\text{ °C}$ ; $T_j \leq 150\text{ °C}$ ; $R_{GS} = 20\text{ k}\Omega$	-	25	V
$V_{GS}$	gate-source voltage		-20	20	V
$I_D$	drain current	$V_{GS} = 10\text{ V}$ ; $T_{mb} = 100\text{ °C}$ ; see <a href="#">Figure 1</a>	-	100	A
		$V_{GS} = 10\text{ V}$ ; $T_{mb} = 25\text{ °C}$ ; see <a href="#">Figure 1</a> ; see <a href="#">Figure 3</a>	[1]	100	A
$I_{DM}$	peak drain current	$t_p \leq 10\text{ }\mu\text{s}$ ; pulsed; $T_{mb} = 25\text{ °C}$ ; see <a href="#">Figure 3</a>	-	697	A
$P_{tot}$	total power dissipation	$T_{mb} = 25\text{ °C}$ ; see <a href="#">Figure 2</a>	-	104	W
$T_{stg}$	storage temperature		-55	150	°C
$T_j$	junction temperature		-55	150	°C
<b>Source-drain diode</b>					
$I_S$	source current	$T_{mb} = 25\text{ °C}$ ; [1]	-	100	A
$I_{SM}$	peak source current	$t_p \leq 10\text{ }\mu\text{s}$ ; pulsed; $T_{mb} = 25\text{ °C}$	-	697	A
<b>Avalanche ruggedness</b>					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$V_{GS} = 10\text{ V}$ ; $T_{j(\text{init})} = 25\text{ °C}$ ; $I_D = 100\text{ A}$ ; $V_{sup} \leq 25\text{ V}$ ; $t_p = 0.15\text{ ms}$ ; $R_{GS} = 50\text{ }\Omega$ ; unclamped	-	239	mJ

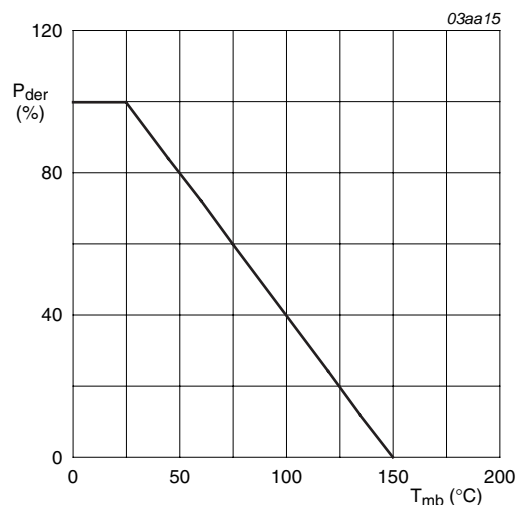
[1] Continuous current is limited by package.



$$V_{GS} \geq 10V$$

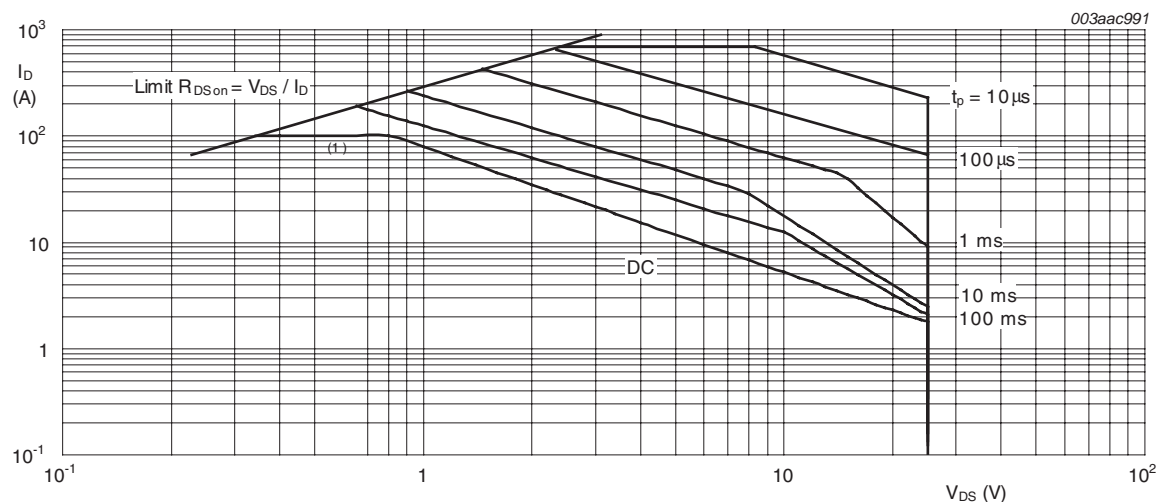
(1) Capped at 100 A due to package.

**Fig 1. Continuous drain current as a function of mounting base temperature**



$$P_{der} = \frac{P_{tot}}{P_{tot(25^\circ C)}} \times 100\%$$

**Fig 2. Normalized total power dissipation as a function of mounting base temperature**



$$T_{mb} = 25^\circ C; I_{DM} \text{ is single pulse}$$

(1) Capped at 100 A due to package.

**Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage**

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see <a href="#">Figure 4</a>	-	-	1.2	K/W

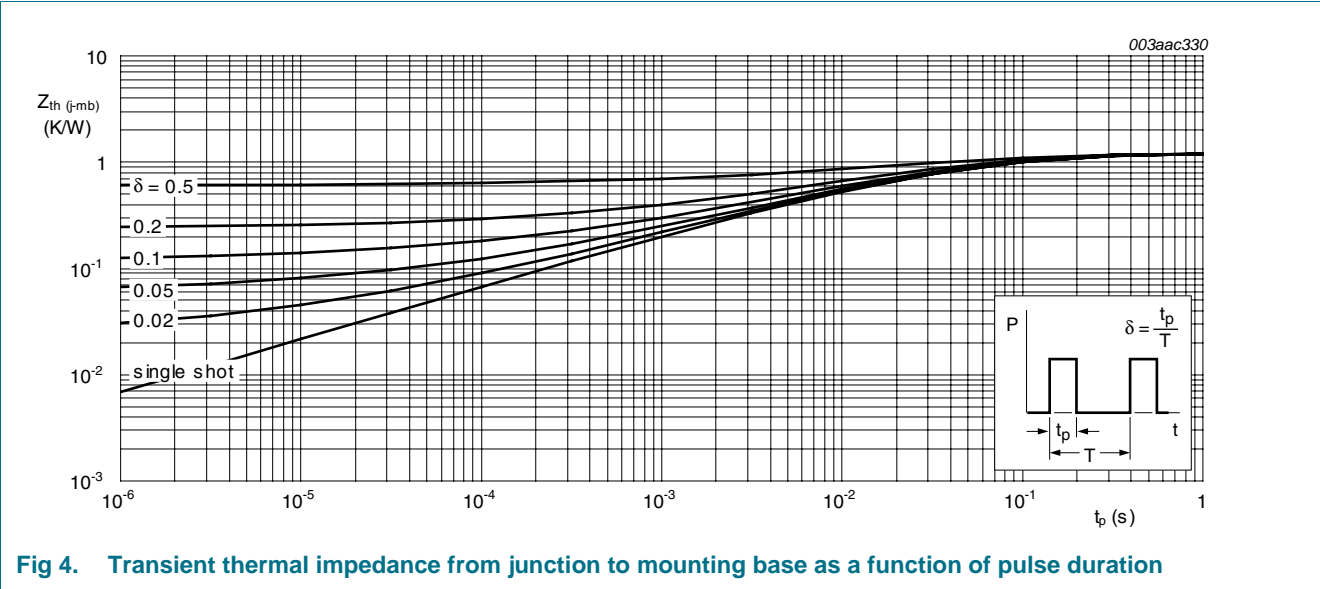


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 6. Characteristics

**Table 6. Characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A$ ; $V_{GS} = 0 V$ ; $T_j = 25 ^\circ C$	25	-	-	V
		$I_D = 250 \mu A$ ; $V_{GS} = 0 V$ ; $T_j = -55 ^\circ C$	23.2	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 mA$ ; $V_{DS} = V_{GS}$ ; $T_j = 25 ^\circ C$ ; see <a href="#">Figure 8</a> ; see <a href="#">Figure 9</a>	1.3	1.7	2.15	V
		$I_D = 1 mA$ ; $V_{DS} = V_{GS}$ ; $T_j = 150 ^\circ C$ ; see <a href="#">Figure 8</a> ; see <a href="#">Figure 9</a>	0.65	-	-	V
		$I_D = 1 mA$ ; $V_{DS} = V_{GS}$ ; $T_j = -55 ^\circ C$ ; see <a href="#">Figure 8</a> ; see <a href="#">Figure 9</a>	-	-	2.45	V
$I_{DSS}$	drain leakage current	$V_{DS} = 25 V$ ; $V_{GS} = 0 V$ ; $T_j = 25 ^\circ C$	-	-	1	$\mu A$
		$V_{DS} = 25 V$ ; $V_{GS} = 0 V$ ; $T_j = 150 ^\circ C$	-	-	100	$\mu A$
$I_{GSS}$	gate leakage current	$V_{GS} = 16 V$ ; $V_{DS} = 0 V$ ; $T_j = 25 ^\circ C$	-	-	100	nA
		$V_{GS} = -16 V$ ; $V_{DS} = 0 V$ ; $T_j = 25 ^\circ C$	-	-	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 4.5 V$ ; $I_D = 25 A$ ; $T_j = 25 ^\circ C$ ; see <a href="#">Figure 10</a>	-	2	2.7	m $\Omega$
		$V_{GS} = 10 V$ ; $I_D = 25 A$ ; $T_j = 150 ^\circ C$ ; see <a href="#">Figure 10</a>	-	2.4	3.1	m $\Omega$
		$V_{GS} = 10 V$ ; $I_D = 25 A$ ; $T_j = 25 ^\circ C$ ; see <a href="#">Figure 10</a> ; see <a href="#">Figure 11</a>	-	1.4	1.8	m $\Omega$
$R_G$	gate resistance	$f = 1 MHz$	-	0.95	1.5	$\Omega$
<b>Dynamic characteristics</b>						
$Q_{G(tot)}$	total gate charge	$I_D = 25 A$ ; $V_{DS} = 12 V$ ; $V_{GS} = 4.5 V$ ; see <a href="#">Figure 12</a> ; see <a href="#">Figure 13</a>	-	31	-	nC
		$I_D = 0 A$ ; $V_{DS} = 0 V$ ; $V_{GS} = 4.5 V$	-	24.5	-	nC
$Q_{GS}$	gate-source charge	$I_D = 25 A$ ; $V_{DS} = 12 V$ ; $V_{GS} = 4.5 V$ ; see <a href="#">Figure 12</a> ; see <a href="#">Figure 13</a>	-	10.4	-	nC
$Q_{GS(th)}$	pre-threshold gate-source charge		-	5.4	-	nC
$Q_{GS(th-pl)}$	post-threshold gate-source charge		-	5	-	nC
$Q_{GD}$	gate-drain charge		-	8	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$V_{DS} = 12 V$ ; see <a href="#">Figure 12</a> ; see <a href="#">Figure 13</a>	-	2.54	-	V
$C_{iss}$	input capacitance	$V_{DS} = 12 V$ ; $V_{GS} = 0 V$ ; $f = 1 MHz$ ; $T_j = 25 ^\circ C$ ; see <a href="#">Figure 14</a>	-	4300	-	pF
		$V_{DS} = 0 V$ ; $V_{GS} = 0 V$ ; $f = 1 MHz$ ; $T_j = 25 ^\circ C$	-	4800	-	pF
$C_{oss}$	output capacitance	$V_{DS} = 12 V$ ; $V_{GS} = 0 V$ ; $f = 1 MHz$ ; $T_j = 25 ^\circ C$ ; see <a href="#">Figure 14</a>	-	1100	-	pF
$C_{rss}$	reverse transfer capacitance		-	390	-	pF

Table 6. Characteristics ...continued

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t <sub>d(on)</sub>	turn-on delay time	V <sub>DS</sub> = 12 V; R <sub>L</sub> = 0.5 Ω; V <sub>GS</sub> = 4.5 V; R <sub>G(ext)</sub> = 5.6 Ω	-	47	-	ns
t <sub>r</sub>	rise time		-	72	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	54	-	ns
t <sub>f</sub>	fall time		-	29	-	ns
Source-drain diode						
V <sub>SD</sub>	source-drain voltage	I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C; see <a href="#">Figure 15</a>	-	0.82	1.2	V
t <sub>rr</sub>	reverse recovery time	I <sub>S</sub> = 20 A; dI <sub>S</sub> /dt = -100 A/s; V <sub>GS</sub> = 0 V;	-	43	-	ns
Q <sub>r</sub>	recovered charge	V <sub>DS</sub> = 25 V	-	53	-	nC

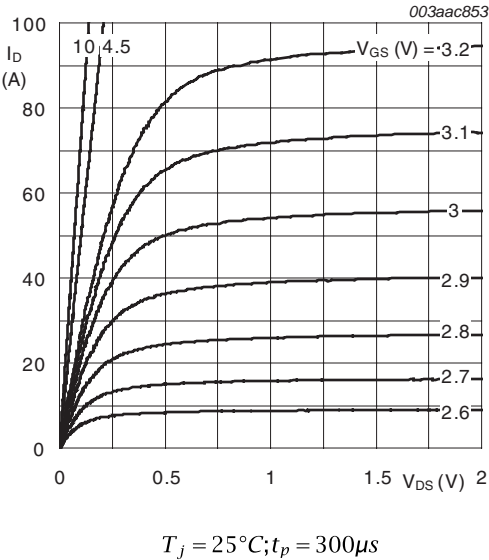


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

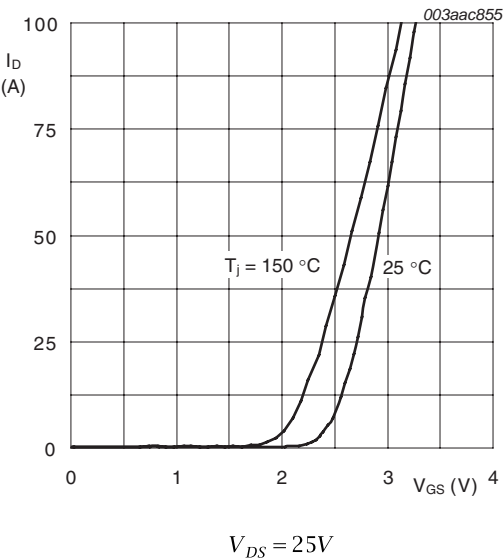
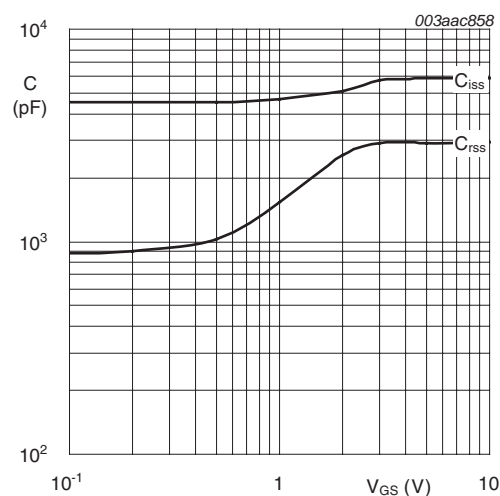
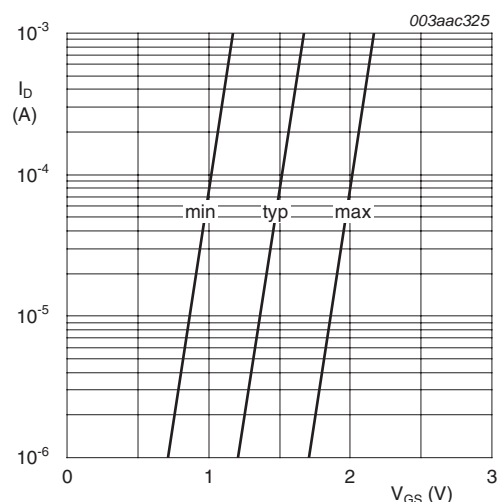


Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values



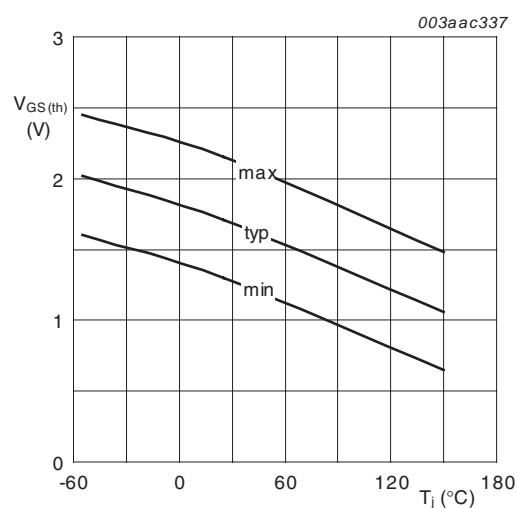
$$V_{DS} = 0V; f = 1MHz$$

**Fig 7.** Input and reverse transfer capacitances as a function of gate-source voltage; typical values



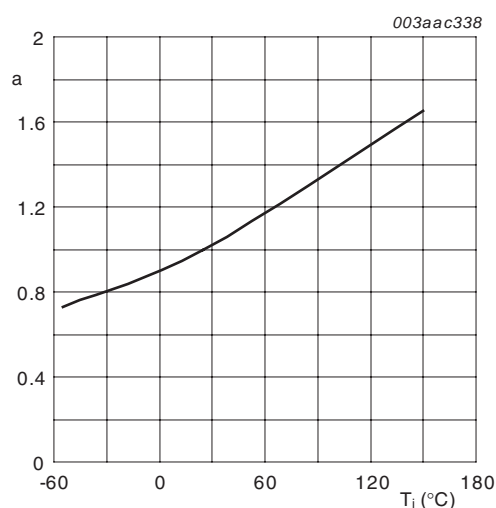
$$T_j = 25^\circ C; V_{DS} = 25V$$

**Fig 8.** Sub-threshold drain current as a function of gate-source voltage



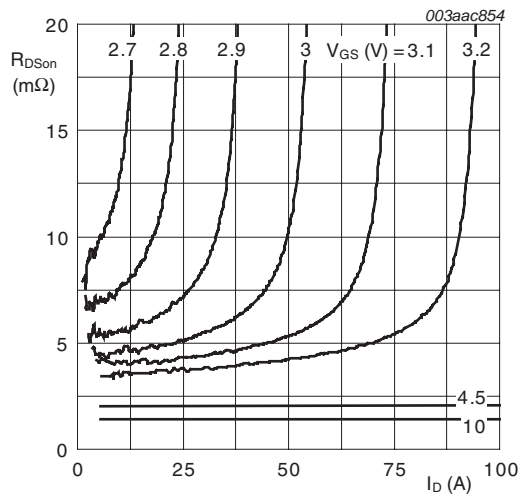
$$I_D = 1mA; V_{DS} = V_{GS}$$

**Fig 9.** Gate-source threshold voltage as a function of junction temperature



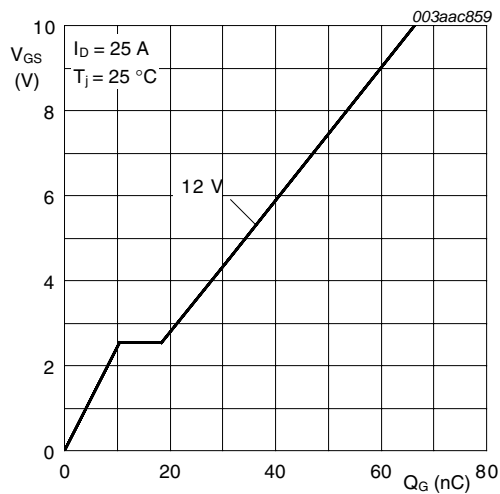
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ C)}}$$

**Fig 10.** Normalized drain-source on-state resistance factor as a function of junction temperature



$T_j = 25^\circ C$

Fig 11. Drain-source on-state resistance as a function of drain current; typical values.



$T_j = 25^\circ C; I_D = 25 A$

Fig 13. Gate-source voltage as a function of turn-on gate charge; typical values.

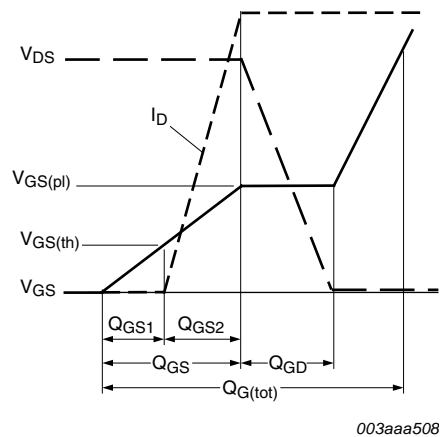
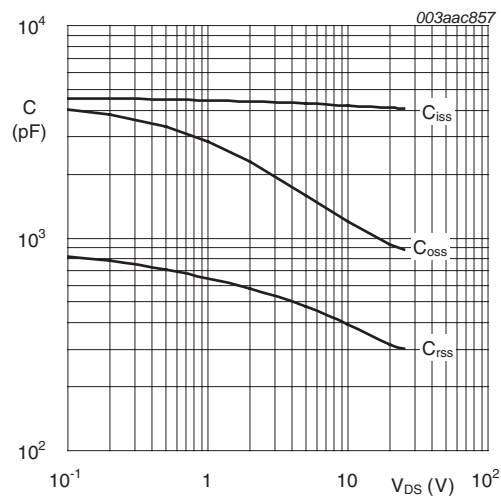


Fig 12. Gate charge waveform definitions



$V_{GS} = 0V; f = 1MHz$

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



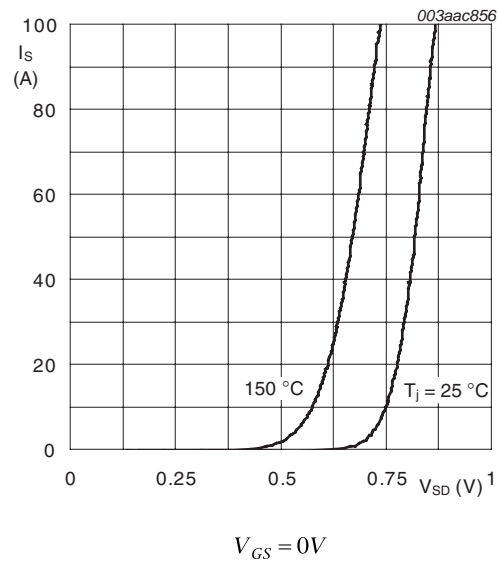


Fig 15. Source current as a function of source drain voltage; typical values.

7. Package outline

Plastic single-ended surface-mounted package (LFAK); 4 leads

SOT669

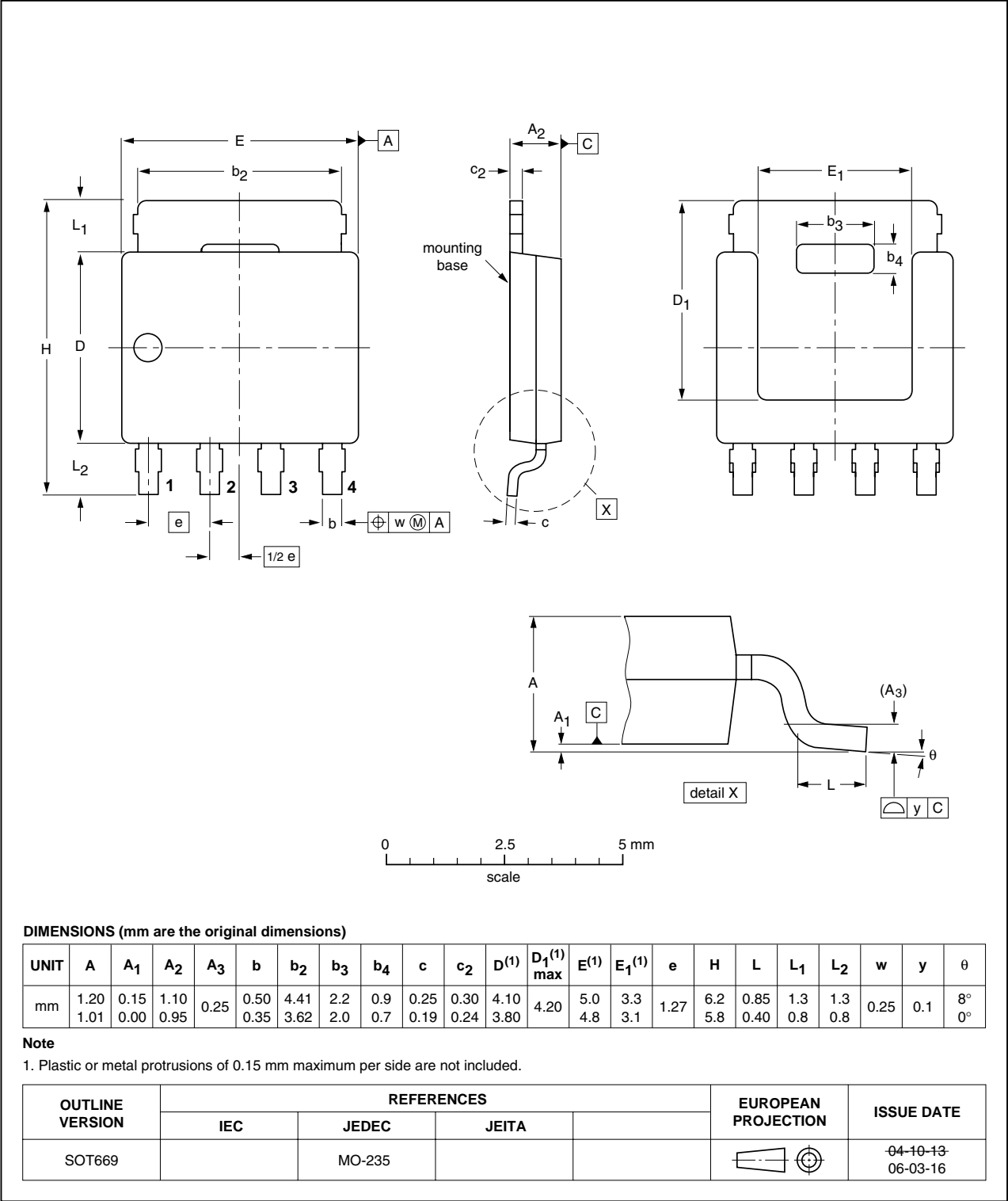


Fig 16. Package outline SOT669 (LFAK)

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PH1825AL_1	20090422	Product data sheet	-	-

## 9. Legal information

### 9.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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11. Contents

1 Product profile .....1

1.1 General description .....1

1.2 Features and benefits .....1

1.3 Applications .....1

1.4 Quick reference data .....1

2 Pinning information .....2

3 Ordering information .....2

4 Limiting values .....2

5 Thermal characteristics .....4

6 Characteristics .....5

7 Package outline .....10

8 Revision history .....11

9 Legal information .....12

9.1 Data sheet status .....12

9.2 Definitions .....12

9.3 Disclaimers .....12

9.4 Trademarks .....12

10 Contact information .....12



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